

**Search Notes**

Application/Control No.

10/805,365

Examiner

VanThu Nguyen

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.01 185.02 o 185.05	11/16/2005	VTN
	185.18 x		
	189.01		
	189.09 x		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search (see print out history)	11/16/2005	VTN